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| Notice of References Cited | Application/Control No. 10/628,565 | | Applicant(s)/Patent Under Reexamination SCHULZ ET AL. | |
| | Examiner Neil R. Kardos | | Art Unit 4172 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-5,630,069 A | 05-1997 | Flores et al. | 705/7 |
| * | B | US-5,826,020 A | 10-1998 | Randell, Jim | 709/202 |
| * | C | US-6,052,684 A | 04-2000 | Du, Weimin | 707/8 |
| * | D | US-6,073,109 A | 06-2000 | Flores et al. | 705/8 |
| * | E | US-6,349,238 B1 | 02-2002 | Gabbita et al. | 700/101 |
| * | F | US-6,920,456 B2 | 07-2005 | Lee et al. | 707/101 |
| * | G | US-7,039,597 B1 | 05-2006 | Notani et al. | 705/9 |
| * | H | US-7,184,966 B1 | 02-2007 | Parsonnet et al. | 705/8 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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